

Invited

Enhancement of the Magneto-Optical Kerr Rotation in Magnetic Multilayered Films

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Magnetic compositionally modulated multilayer films (CMF) containing noble metals were prepared and its magnetic and magneto-optical properties were investigated. As the results, an enhancement of magneto-optical Kerr rotation θ_K was observed at the plasma edge of noble metals. The magnitude of θ_K peak becomes larger than those of Fe and Co metals when the CMF's have a suitable layer thickness ratio of magnetic to noble metals. And, it turns out also that there is an optimum value of the modulation length D for the enhancement of θ_K . These spectra are explainable principally by numerical calculation of θ_K using a virtual optical constants.

1. INTRODUCTION

Compositionally modulated multilayer films (CMF, artificial superlattice) have attracted great interests. So far, many magnetic CMF systems have been investigated and interesting phenomena such as the occurrence of long range helimagnetic ordering and perpendicular anisotropy have been reported for a certain kinds of magnetic CMF's.^{1),2)} We have reported that an enhancement of θ_K is observed at the plasma edge of noble metals in the CMF's such as Fe/Cu, Co/Cu, Fe/Au, Co/Au, Co/Ag, etc.^{3)~5)}

The magneto-optical Kerr effect is of considerable interest because of usefulness for read-out in magneto-optical memory systems. For these applications, a large Kerr effect is required. In this paper, we report mainly the studies of polar Kerr rotation (θ_K) spectra in the CMF's which consist of 3d magnetic metals of Fe or Co and noble metals of Cu, Au and Ag. And we report also the studies on CMF's containing Pt and Pd which are expected to be spin-polarized by the proximity effect with magnetic elements.

2. EXPERIMENTAL PROCEDURES

All CMF samples were deposited on rotating glass substrates by means of RF sputtering using two or three targets. A grounded shroud was used as an isolator to avoid mixing of sputtered atoms. The substrate temperature was maintained at about 20°C by water cooling during the film deposition. The compositionally modulation length (D) was controlled by the rotating speed of the substrate under the constant sputtering conditions.

The crystal structure and D were examined by both low and high angle X-ray diffraction methods. θ_K spectra were measured with a Kerr spectrometer (Jasco K-250) in the wavelength region from 250 to 800nm under the condition of saturation magnetization. The incident angle of light was 10° from the normal to the surface of CMF. The total film thickness was checked by a talystep. Each layer thickness of CMF was determined from the deposition rates of the component metals.

3. EXPERIMENTAL RESULTS

3-1. X-RAY DIFFRACTION

Structures of all CMF's was examined by

both low and high angle X-ray diffraction methods. A presence of the periodic structure was confirmed beyond $\sim 9\text{\AA}$ for Co/Cu, Fe/Cu, Co/Au, Fe/Au, Co/Pt and beyond $\sim 15\text{\AA}$ for Fe/Ag, Co/Ag CMF's. And it is considered that the crystallinity of CMF's containing Au and Pt is, in general, better than that of Fe/Ag and Fe/Cu CMF's from the results of the high angle X-ray diffraction.

3-2. MAGNETO-OPTICAL KERR EFFECT

Figure 1 shows the wavelength dependence of θ_K (spectra) in Fe/Cu CMF's with the layer thickness ratio of about 0.62. The value of θ_K is low and the spectrum is relatively simple in Fe(5Å)/Cu(9Å) CMF. Namely, no θ_K peak is observed at wavelength from 300 to 800nm. The spectrum is similar to that of sputtered solid solution alloy of Fe and Cu metals. However, a new peak of θ_K appears around 560nm, corresponding to the coupled plasma edge of the free carrier in Cu metal, in Fe(15Å)/Cu(25Å) and Fe(30Å)/Cu(50Å) CMF's. These spectra are quite different from that of Fe metal film. Here, the plasma edge is coupled with interband transitions in Cu, where the real part of the diagonal dielectric tensor approaches zero and reflectivity R decreases considerably. In Co/Cu CMF's, a similar enhancement of θ_K was observed at the same wavelength corresponding to the plasma edge of Cu.

Figure 2 and 3 show the θ_K spectra of in Co/Au and Co/Ag CMF's with several kinds of D . These results are similar to the cases of Co/Cu and Fe/Cu CMF's except for the wavelength where the θ_K peak appears. Namely, in large D region, a new peak appears around $\lambda=500$ and 310nm corresponding to the plasma edge of Au and Ag, respectively. A similar θ_K enhancement appears also in Fe/Au and Fe/Ag CMF's systems.

Thus, it turned out that θ_K is enhanced around the wavelength which corresponds to

the plasma edge of noble metals in magnetic CMF's with relatively large D . Therefore, we have studied the layer thickness ratio dependence of θ_K spectra in Fe/Cu CMF's. From the experiments, it is found that the enhancement of θ_K is sensitive to the thickness ratio of

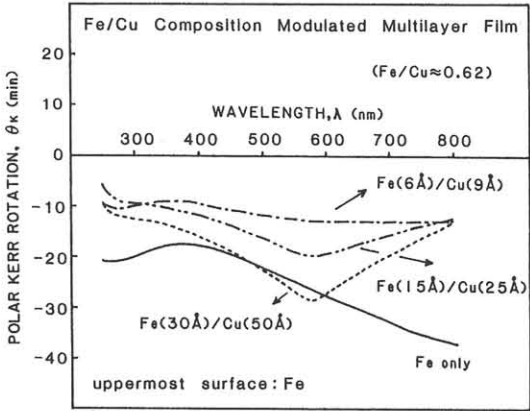


Fig.1 θ_K spectra in three kinds of Fe/Cu CMF's. The θ_K spectrum of Fe metal film is shown as a comparison. The Fe/Cu layer thickness ratio is about 0.62.

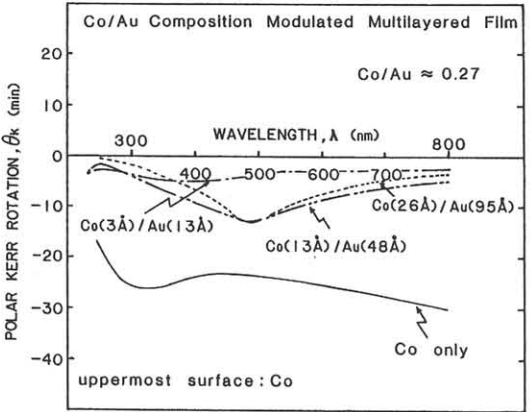


Fig.2 θ_K spectra in Co/Au CMF's with different D .

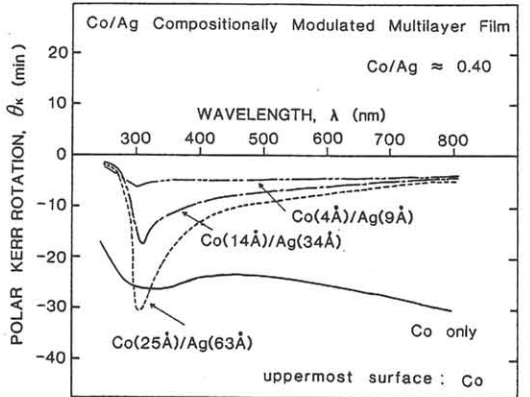


Fig.3 θ_K spectra in Co/Ag CMF's with different D .

Fe and Cu layers and θ_K peak moves towards the longer wavelength side with increasing D. Namely, there are optimum values of both Fe/Cu thickness ratio and D for the maximum enhancement of θ_K .

In order to make clear the mechanism of the enhancement of θ_K , we measured the behaviours of θ_K spectra in these bilayer systems.⁶⁾ θ_K enhancement is observed also in magnetic bilayer systems such as Fe/Cu, Co/Ag. It is found that, in the Fe/Cu system, when the Fe is very thin, θ_K is low and it becomes zero in the wavelength region beyond 700nm. However, as the Fe layer becomes thicker, θ_K peak appears around 560nm corresponding to the plasma edge of Cu. θ_K peak reaches up to a maximum value, which is larger than that of multilayers, at Fe= \sim 130Å and then it moves towards the longer wavelength side and decreases with the increase of Fe layer thickness.

4. DISCUSSION

Regarding an origin of the θ_K enhancement phenomena observed here, we considered the following three possibilities: 1) Proximity effect associated with spin polarization, 2) optical multiple interference effect, and 3) Plasma resonance effect.

When the proximity effect of magnetic layers is effective, it is probable that the electronic band structure of noble metal is modified by adjacent magnetic layers and that the spin polarization is induced in the noble metal layers by this proximity effect. In this cases, the Kerr rotation will increase with increasing the number of the interfaces, namely, decreasing D. However, the experimental results without Pt and Pd systems are opposite to the prediction in the range of optical penetration depth.

It is considered that an ordinary interference effect does not play a responsible role for the appearance of θ_K peak in these

Fe/Cu CMF's, since the R does not drop considerably at the wavelength of plasma edge. From the results of numerical calculations, however, it is probable that the zeroth order multiple reflection occurs in the bilayered system.

K.Sato et al. have analyzed the θ_K spectra in Fe/Cu CMF's based on the calculations using virtual optical constants.⁷⁾ And they showed that the calculated θ_K spectra are in good agreement with the experimental results and the enhancement of θ_K in Fe/Cu CMF's appeared around the plasma edge of Cu is interpreted in terms of the existence of hybrid plasma in these materials. In Fig.4 are shown the calculated θ_K spectra for Fe/Cu CMF's taking D as a parameter.⁷⁾ The ratio of Fe/Cu thickness is \sim 0.62. The calculated spectra are similar to the experimental results although the peak positions of θ_K are slightly different. In this figure, we can clearly observe the θ_K enhancement around 560nm. They also indicated that the calculated R spectra are in good agreement with the experimental data.

Feil and Haas have reported the θ_K enhancement due to the plasma resonance of free carriers in metallic magnetic substance.⁸⁾ It is probable that the effective dielectric constants nearly satisfy the condition of the

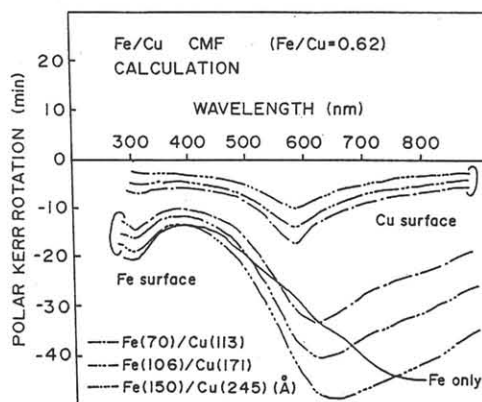


Fig.4 Calculated θ_K spectra in various kinds of Fe/Cu CMF's.⁶⁾ The curves of CMF's with the top surface of Fe or Cu are indicated. And calculated θ_K spectrum of Fe is also shown as a comparison. Fe/Cu layer thickness ratio is kept constant (=0.62).

plasma resonance enhancement in the CMF's with the D smaller than the wavelength of light. We think that the results show that the plasma resonance enhancement of θ_K , which has been reported on TmS, etc.⁹⁾, can be realized in the multilayer films.

Although we are interested in the possibility of θ_K enhancement originated from a spin polarization effect of the band near the Fermi level of non-magnetic elements, it is concluded that the above mentioned θ_K enhancement is ascribed to the modification of the optical constants due to the plasma resonance effect. As an attempt of finding

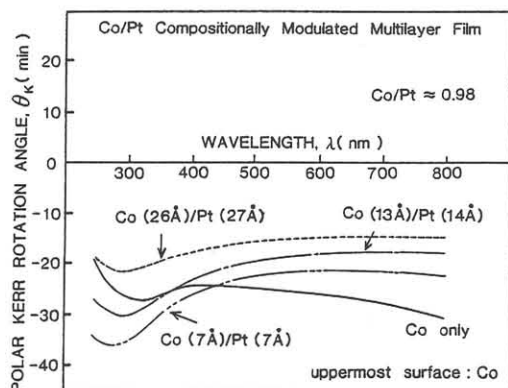


Fig.5 θ_K spectra in Co/Pt CMF's with different D.

of new θ_K enhancement due to spin polarization of non-magnetic metals such as Pt, Pd, we measured the θ_K spectra of Co/Pt, Co/Pd etc. As an example, in Fig.5 are shown the θ_K spectra in several Co/Pt CMF's with almost constant layer thickness ratio. θ_K peaks are located around 290nm and its magnitude becomes larger with the decreasing D contrary to that of the CMF's such as Fe/Cu, Co/Ag, etc. Moreover, the magnitude of θ_K peak is somewhat larger than that of the alloys with the same composition. In Fe/Pt CMF's, it is found that θ_K peak moves slightly to the shorter wavelength side. Until now, however, it is not confirmed yet that the θ_K peaks are originated from the polarization of Pt near interfaces.

We believe that the phenomena described here will provide a promising method for en-

hancement of θ_K in magneto-optical storage media.

5. CONCLUSION

The structure and the θ_K spectra of magnetic CMF's containing 3d transition and noble metals have been investigated. It is found that, though the θ_K spectra is simple in cases of relatively small D, a new θ_K peak appears around the wavelength which corresponds to the plasma edge of noble metals with the increase of D. There are optimum values of both layer thickness ratio and D in CMF's for the enhancement of θ_K . Moreover, the enhancement of θ_K depends on the species of the top surface, namely, whether it is magnetic or non-magnetic. A similar θ_K enhancement occurs also around the plasma edges of noble metals in the bilayered films. All these θ_K behaviors can be explainable principally by the numerical calculation using a virtual optical constants. The θ_K enhancement is observed around 290nm in CMF system containing Pt.

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